



Used in Lieu of PTO/SB/08/A/B  
(Based on PTO 11-07 version)

Substitute for form 1449/PTO				<i>Complete if Known</i>	
				Application Number	10/812,177-Conf. #3379
				Filing Date	March 29, 2004
				First Named Inventor	Keisuke inoue
				Art Unit	2128
				Examiner Name	S. A. Alhija
Sheet	1	of	1	Attorney Docket Number	SCEI 3.0-170

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			

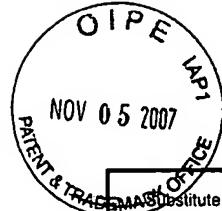
FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)			

<sup>1</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. <sup>2</sup>CITE NO.: Those application(s) which are marked with a single asterisk (\*) next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IFW. <sup>3</sup>Applicant's unique citation designation number (optional). <sup>4</sup>See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>5</sup>Enter Office that issued the document, by the two-letter code (WPO Standard ST.3). <sup>6</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>7</sup>Kind of document by the appropriate symbols as indicated on the document under WPO Standard ST.16 if possible. <sup>8</sup>Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			<sup>2</sup>
SA	CA	Office Action dated 9/28/07 from corresponding Chinese Patent Application No.: 200580010385.9 with English Translation, 20 pages.			✓

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				Complete if Known	
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		Number-Kind Code <sup>2</sup> (if known)	MM-DD-YYYY		
SP	AA	US-6,948,082	09-20-2005	Gschwind et al.	
	AB	US-2002116654	08-22-2002	Rosch Winn et al	
	AC	US-5,754,436	05-19-1998	Walsh et al.	
	AD	US-6,564,328	05-13-2003	Grochowski et al.	
	AE	US-7,043,648	05-09-2006	Tokunaga et al.	
	AF	US-6,976,178	12-13-2005	Kissell et al.	
	AG	US-7,096,145	08-22-2006	Orenstien et al.	

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SP	BA	EP-1096360	05-02-2001	Texas Instruments Incorporated	

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SP	CA	ANOOP IYER, DIANA MARCULESCU: "Power Aware Microarchitecture Resource Scaling" Design, Automation and Test in Europe, Conference and Exhibition March 13, 2001, pp. 190-196 (7 pages).			
SP	CB	Taku, Yasui "Linux Kernel for beginners, Part 3, Processing scheduling", Nikkei Linux, Nikkei BP, November 8, 2003, Vol. 5, No. 11, pp. 97-103 (CS-ND-2004-01116-007)			

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Examiner Signature	Sin NL	Date Considered	1/31/08
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